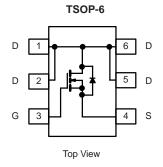


N-Channel 30 V (D-S) MOSFET

| PRODUCT SUMMARY | | | | | | | |
|---------------------|----------------------------------|------------------------------------|-----------------------|--|--|--|--|
| V _{DS} (V) | $R_{DS(on)}\left(\Omega\right)$ | I _D (A) ^{a, e} | Q _g (Typ.) | | | | |
| 30 | 0.023 at V _{GS} = 10 V | 6 | 4.2 nC | | | | |
| 30 | 0.027 at V _{GS} = 4.5 V | 6 | 4.2110 | | | | |



FEATURES

- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET[®] Power MOSFET
- Low On-Resistance
- 100 % R_g Tested
- Compliant to RoHS Directive 2002/95/EC



APPLICATIONS

• DC/DC Converters, High Speed Switching

| ABSOLUTE MAXIMUM RATIN | GS (T _A = 25 °C | , unless othe | rwise noted) | |
|--|-----------------------------------|--------------------|---------------------|----|
| Parameter | Symbol | Limit | Unit | |
| Drain-Source Voltage | | V _{DS} | 30 | V |
| Gate-Source Voltage | | V_{GS} | ± 20 | V |
| | T _C = 25 °C | | 6 ^e | |
| Continuous Drain Current (T _J = 150 °C) | T _C = 70 °C | | 6 ^e | |
| Continuous Diam Current (1) = 130 °C) | T _A = 25 °C | l _D | 5.5 ^{b, c} | |
| | T _A = 70 °C | | 4.4 ^{b, c} | A |
| Pulsed Drain Current (t = 300 μs) | Pulsed Drain Current (t = 300 μs) | | 25 | |
| Continuous Source-Drain Diode Current | T _C = 25 °C | 1. | 2.1 | |
| Continuous Source-Drain Diode Current | T _A = 25 °C | - I _S - | 1.1 ^{b, c} | |
| | T _C = 25 °C | | 2.5 | |
| Maximum Power Dissipation | T _C = 70 °C | P _D | 1.6 | W |
| Maximum Fower Dissipation | T _A = 25 °C | | 1.3 ^{b, c} | VV |
| | T _A = 70 °C | | 0.8 ^{b, c} | |
| Operating Junction and Storage Temperature | T _J , T _{stg} | - 55 to 150 | °C | |
| Soldering Recommendations (Peak Tempera | | 260 | | |

| THERMAL RESISTANCE RATINGS | | | | | | | |
|---|--------------|-------------------|---------|------|--------|--|--|
| Parameter | Symbol | Typical | Maximum | Unit | | | |
| Maximum Junction-to-Ambient ^{b, d} | t ≤ 5 s | R _{thJA} | 75 | 100 | °C/W | | |
| Maximum Junction-to-Foot (Drain) | Steady State | R_{thJF} | 40 | 50 | C/ V V | | |

Notes:

- a. Based on $T_C = 25$ °C.
- b. Surface mounted on 1" x 1" FR4 board.
- c t = 5 s
- d. Maximum under steady state conditions is 166 °C/W.
- e. Package limited.

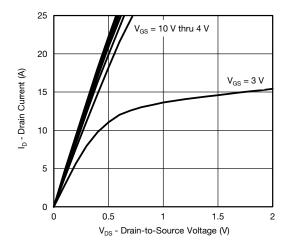


| Parameter | Symbol | Test Conditions | Min. | Тур. | Max. | Unit |
|---|-------------------------|--|------|----------|-------|-------|
| Static | - | | | | L | |
| Drain-Source Breakdown Voltage | V _{DS} | $V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$ | 30 | | | V |
| V _{DS} Temperature Coefficient | $\Delta V_{DS}/T_{J}$ | J 250 A | | 30 | | mV/°C |
| V _{GS(th)} Temperature Coefficient | $\Delta V_{GS(th)}/T_J$ | I _D = 250 μA | | - 4.8 | | |
| Gate-Source Threshold Voltage | V _{GS(th)} | $V_{DS} = V_{GS}$, $I_{D} = 250 \mu A$ | 0.5 | | 1.5 | V |
| Gate-Source Leakage | I _{GSS} | $V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$ | | | ± 100 | nA |
| | I _{DSS} | $V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$ | | | 1 | μΑ |
| Zero Gate Voltage Drain Current | | V _{DS} = 30 V, V _{GS} = 0 V, T _J = 70 °C | | | 10 | |
| On-State Drain Current ^a | I _{D(on)} | $V_{DS} \le 5 \text{ V}, V_{GS} = 10 \text{ V}$ | 20 | | | Α |
| | | $V_{GS} = 10 \text{ V}, I_D = 5.5 \text{ A}$ | | 0.023 | | Ω |
| Drain-Source On-State Resistance ^a | R _{DS(on)} | V _{GS} = 4.5 V, I _D = 5 A | | 0.027 | | |
| Forward Transconductance ^a | 9 _{fs} | V _{DS} = 15 V, I _D = 5.5 A | | 24 | | S |
| Dynamic ^b | | | | <u> </u> | | |
| Input Capacitance | C _{iss} | | | 424 | | |
| Output Capacitance | C _{oss} | $V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$ | | 100 | | pF |
| Reverse Transfer Capacitance | C _{rss} | 30 | | 42 | | |
| | Q _g | V _{DS} = 15 V, V _{GS} = 10 V, I _D = 5.5 A | | 8.2 | 13 | nC |
| Total Gate Charge | | 20 7 00 7 0 | | 4.2 | 7 | |
| Gate-Source Charge | Q _{gs} | $V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 5.5 \text{ A}$ | | 1.4 | | |
| Gate-Drain Charge | Q _{gd} | | | 1.4 | | |
| Gate Resistance | R _g | f = 1 MHz | 2.5 | 12.6 | 25.2 | Ω |
| Turn-On Delay Time | t _{d(on)} | | | 6 | 12 | _ |
| Rise Time | t _r | $V_{DD} = 15 \text{ V, R}_{1} = 3.4 \Omega$ | | 20 | 30 | |
| Turn-Off Delay Time | t _{d(off)} | $I_D \approx 4.4 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$ | | 14 | 21 | |
| Fall Time | t _f | , and the second | | 10 | 20 | |
| Turn-On Delay Time | t _{d(on)} | | | 3 | 6 | ns |
| Rise Time | t _r | $V_{DD} = 15 \text{ V, R}_{L} = 3.4 \Omega$ | | 11 | 20 | |
| Turn-Off Delay Time | t _{d(off)} | $I_D \approx 4.4 \text{ A}, V_{GEN} = 10 \text{ V}, R_a = 1 \Omega$ | | 20 | 30 | |
| Fall Time | t _f | ů . | | 7 | 14 | |
| Drain-Source Body Diode Characteristic | cs | | | | l | |
| Continuous Source-Drain Diode Current | I _S | T _C = 25 °C | | | 2.1 | |
| Pulse Diode Forward Current | I _{SM} | | | | 25 | A |
| Body Diode Voltage | V _{SD} | I _S = 4.4 A, V _{GS} = 0 V | | 0.82 | 1.2 | V |
| Body Diode Reverse Recovery Time | t _{rr} | | | 13 | 20 | ns |
| Body Diode Reverse Recovery Charge | Q _{rr} | | | 6 | 12 | nC |
| Reverse Recovery Fall Time | t _a | $I_F = 4.4 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$ | | 8 | | |
| Reverse Recovery Rise Time | t _b | | | 5 | | ns |

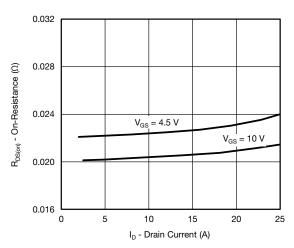
- a. Pulse test; pulse width ≤ 300 μs, duty cycle ≤ 2 %.
 b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

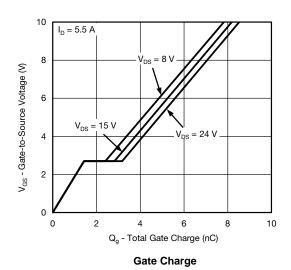




Output Characteristics



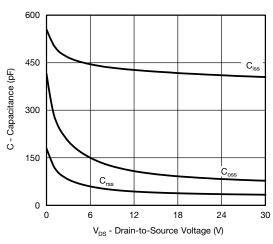
On-Resistance vs. Drain Current and Gate Voltage



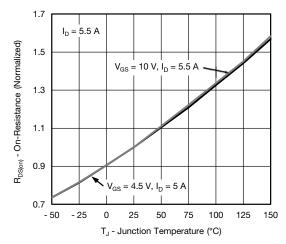
5
4
4
T_C = 25 °C
T_C = -55 °C

0
0
0.5
1
1.5
2
2.5
3
V_{GS} - Gate-to-Source Voltage (V)

Transfer Characteristics

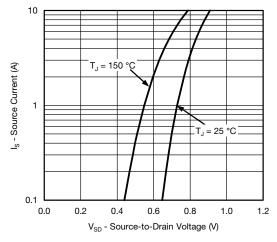


Capacitance

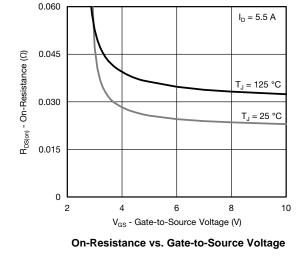


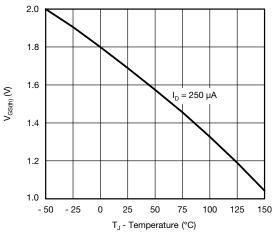
On-Resistance vs. Junction Temperature



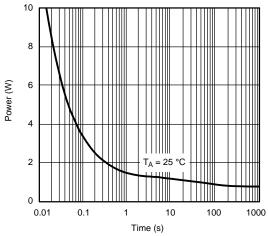


Source-Drain Diode Forward Voltage

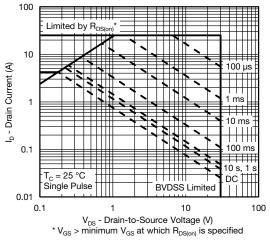




Threshold Voltage

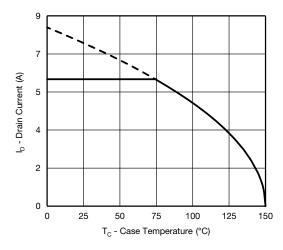


Single Pulse Power (Junction-to-Ambient)

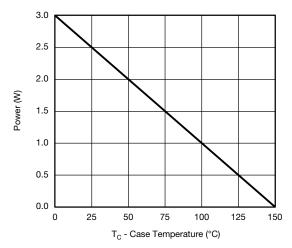


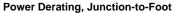
Safe Operating Area, Junction-to-Ambient

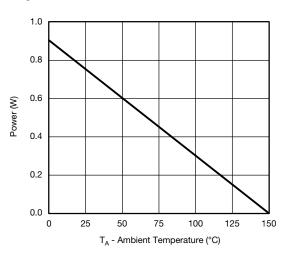




Current Derating*



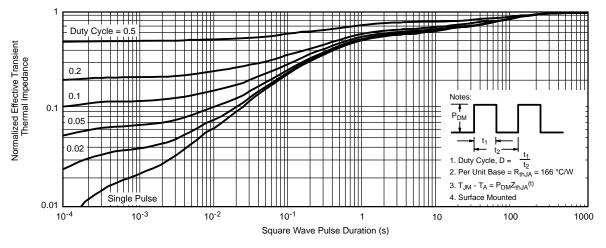




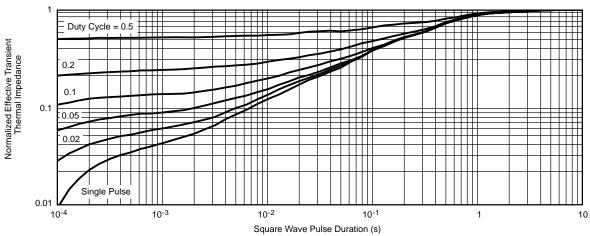
Power Derating, Junction-to-Ambient

^{*} The power dissipation P_D is based on $T_{J(max.)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Ambient

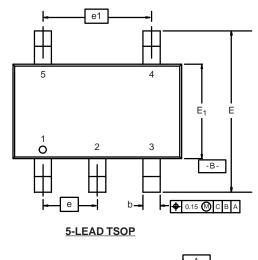


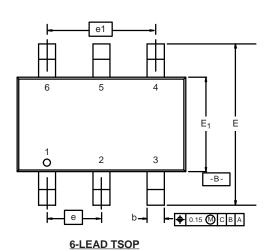
Normalized Thermal Transient Impedance, Junction-to-Foot

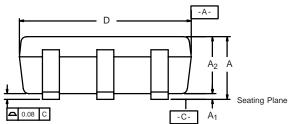


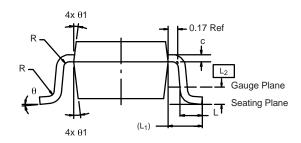
TSOP: 5/6-LEAD

JEDEC Part Number: MO-193C







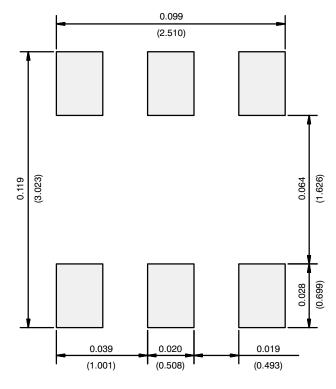


| | MIL | LIMETER | RS | INCHES | | | |
|---|----------|---------|------|------------|-------|-------|--|
| Dim | Min | Nom | Max | Min | Nom | Max | |
| Α | 0.91 | - | 1.10 | 0.036 | - | 0.043 | |
| A ₁ | 0.01 | - | 0.10 | 0.0004 | - | 0.004 | |
| A ₂ | 0.90 | - | 1.00 | 0.035 | 0.038 | 0.039 | |
| b | 0.30 | 0.32 | 0.45 | 0.012 | 0.013 | 0.018 | |
| С | 0.10 | 0.15 | 0.20 | 0.004 | 0.006 | 0.008 | |
| D | 2.95 | 3.05 | 3.10 | 0.116 | 0.120 | 0.122 | |
| Е | 2.70 | 2.85 | 2.98 | 0.106 | 0.112 | 0.117 | |
| E ₁ | 1.55 | 1.65 | 1.70 | 0.061 | 0.065 | 0.067 | |
| е | 0.95 BSC | | | 0.0374 BSC | | | |
| e ₁ | 1.80 | 1.90 | 2.00 | 0.071 | 0.075 | 0.079 | |
| L | 0.32 | - | 0.50 | 0.012 | - | 0.020 | |
| L ₁ | 0.60 Ref | | | 0.024 Ref | | | |
| L ₂ | 0.25 BSC | | | 0.010 BSC | | | |
| R | 0.10 | - | - | 0.004 | - | - | |
| θ | 0° | 4° | 8° | 0° | 4° | 8° | |
| θ_1 | 7° Nom | | | 7° Nom | | | |
| ECN: C-06593-Rev. I, 18-Dec-06 DWG: 5540 | | | | | | | |

8



RECOMMENDED MINIMUM PADS FOR TSOP-6



Recommended Minimum Pads Dimensions in Inches/(mm)



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